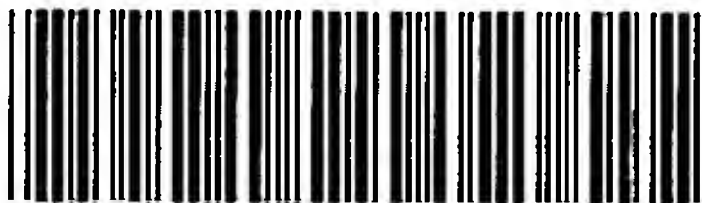


**Search Notes**

Application/Control No.

10/605,234

Examiner

Khiem D. Nguyen

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

2823

**SEARCHED**

Class	Subclass	Date	Examiner
438	246	10/12/2006	K.N.
438	249	10/12/2006	K.N.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	10/12/2006	K.N.